

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10065546	NEIMAN ET AL.
Examiner		Art Unit
Wai, Eric C		2195

SEARCHED

Class	Subclass	Date	Examiner
718	100, 104-105	08/20/2007	ECW
709	104	12/13/2006	ECW
705	5,80	8/27/2009	ECW

SEARCH NOTES

Search Notes	Date	Examiner
Inventor's Name Search	12/13/2006	ECW
East Search	12/13/2006	ECW
Updated East Search	08/20/2007	ECW
Google Scholar Search	1/23/2008	ECW
Updated East Search	11/13/2008	ECW
Updated East Search	5/6/2009	ECW
Updated East Search	8/27/2009	ECW

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
718	104	8/27/2009	ECW